

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/690,560	NAKAHARA ET AL.
	Examiner Khanh Tran	Art Unit 2611

SEARCHED

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
375	all cited	9/20/2007	KCT
370	all cited		